


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/814,369	CHEN ET AL.	
	Examiner	Art Unit	
	/Yonel Beaulieu/	3661	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
701		14			701	3				
INTERNATIONAL CLASSIFICATION										
G	0	5	D	1/00						
				/						
				/						
				/						
				/						

XXXXXXXXXXXX (Assistant Examiner) (Date)		/Yonel Beaulieu/ Yonel Beaulieu (Primary Examiner) (Date)		Total Claims Allowed: 20	
(Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151
2	2			32			62			92			122			152
3	3			33			63			93			123			153
4	4			34			64			94			124			154
5	5			35			65			95			125			155
6	6			36			66			96			126			156
7	7			37			67			97			127			157
8	8			38			68			98			128			158
9	9			39			69			99			129			159
	10			40			70			100			130			160
	11			41			71			101			131			161
	12			42			72			102			132			162
	13			43			73			103			133			163
	14			44			74			104			134			164
	15			45			75			105			135			165
	16			46			76			106			136			166
	17			47			77			107			137			167
	18			48			78			108			138			168
	19		17	49			79			109			139			169
	20		18	50			80			110			140			170
10	21		19	51			81			111			141			171
11	22		20	52			82			112			142			172
12	23			53			83			113			143			173
13	24			54			84			114			144			174
14	25			55			85			115			145			175
15	26			56			86			116			146			176
16	27			57			87			117			147			177
	28			58			88			118			148			178
	29			59			89			119			149			179
	30			60			90			120			150			180
																210